

**Search Notes**

Application/Control No.

10/625,565

Examiner

Dieu-Minh Le

Applicant(s)/Patent under  
Reexamination

KOISHI, TAKAHIRO

Art Unit

2114

**SEARCHED**

Class	Subclass	Date	Examiner
714	11	6/17/2006	DML
714	12	6/17/2006	DML
714	13	6/17/2006	DML

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
714	11	6/17/2006	DML
714	13	6/17/2006	DML

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search files US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM-TDB.	6/17/2006	DML
Inventor name search.	6/17/2006	DML
NPL database search [IEEE & ACM].	6/17/2006	DML
Interference text search - see search history printout.	6/17/2006	DML